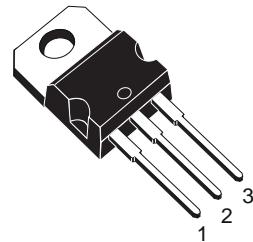


**BUZ10****N - CHANNEL 50V - 0.06Ω - 23A -TO-220
STripFET™ POWER MOSFET**

| TYPE | V _{DSS} | R _{DS(on)} | I _D |
|-------|------------------|---------------------|----------------|
| BUZ10 | 50 V | < 0.055 Ω | 23 A |

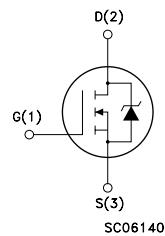
- TYPICAL R_{DS(on)} = 0.06 Ω
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHE TESTED
- HIGH CURRENT CAPABILITY
- 175°C OPERATING TEMPERATURE



TO-220

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- REGULATORS
- DC-DC & DC-AC CONVERTERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- AUTOMOTIVE ENVIRONMENT (INJECTION, ABS, AIR-BAG, LAMPDRIVERS, Etc.)

INTERNAL SCHEMATIC DIAGRAM**ABSOLUTE MAXIMUM RATINGS**

| Symbol | Parameter | Value | Unit |
|------------------|------------------------------------------------------|------------|------|
| V _{DS} | Drain-source Voltage (V _{GS} = 0) | 50 | V |
| V _{DGR} | Drain-gate Voltage (R _{GS} = 20 kΩ) | 50 | V |
| V _{GS} | Gate-source Voltage | ± 20 | V |
| I _D | Drain Current (continuous) at T _c = 25 °C | 23 | A |
| I _{DM} | Drain Current (pulsed) | 92 | A |
| P _{tot} | Total Dissipation at T _c = 25 °C | 75 | W |
| T _{stg} | Storage Temperature | -65 to 175 | °C |
| T _j | Max. Operating Junction Temperature | 175 | °C |
| | DIN HUMIDITY CATEGORY (DIN 40040) | E | |
| | IEC CLIMATIC CATEGORY (DIN IEC 68-1) | 55/150/56 | |

First digit of the datecode being Z or K identifies silicon characterized in this datasheet.

BUZ10

THERMAL DATA

| | | | | |
|-----------------------------------------------|--------------------------------------------------------------------------------|-----|-------------|--------------|
| R _{thj-case} R _{thj-amb} | Thermal Resistance Junction-case Thermal Resistance Junction-ambient Max | Max | 2.0 62.5 | °C/W °C/W |
|-----------------------------------------------|--------------------------------------------------------------------------------|-----|-------------|--------------|

AVALANCHE CHARACTERISTICS

| Symbol | Parameter | Value | Unit |
|-----------------|-------------------------------------------------------------------------------------------------------------------------------|-------|------|
| I _{AR} | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max, δ < 1%) | 23 | A |
| E _{AS} | Single Pulse Avalanche Energy (starting T _j = 25 °C, I _D = I _{AR} , V _{DD} = 30 V) | 70 | mJ |

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

OFF

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|----------------------|-------------------------------------------------------|--------------------------------------------------------------------------------------|------|------|---------|----------|
| V _{(BR)DSS} | Drain-source Breakdown Voltage | I _D = 250 μA V _{GS} = 0 | 50 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current (V _{GS} = 0) | V _{DS} = Max Rating V _{DS} = Max Rating T _j = 125 °C | | | 1 10 | μA μA |
| I _{GSS} | Gate-body Leakage Current (V _{DS} = 0) | V _{GS} = ± 20 V | | | ± 100 | nA |

ON (*)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---------------------|-----------------------------------|---------------------------------------------------------|------|------|------|------|
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} = V _{GS} I _D = 1 mA | 2.1 | 3 | 4 | V |
| R _{D(on)} | Static Drain-source On Resistance | V _{GS} = 10V I _D = 14 A | | 0.06 | 0.07 | Ω |

DYNAMIC

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|----------------------------------------------------------|-------------------------------------------------------------------------|------------------------------------------------------|------|------------------|------|----------------|
| g _{fs} (*) | Forward Transconductance | V _{DS} = 25 V I _D = 14 A | 6 | 11 | | S |
| C _{iss} C _{oss} C _{rss} | Input Capacitance Output Capacitance Reverse Transfer Capacitance | V _{DS} = 25 V f = 1 MHz V _{GS} = 0 | | 900 130 40 | | pF pF pF |

SWITCHING

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------------------------------------------------------|---------------------------------------------------------------|------------------------------------------------------------------------------------------------|------|----------------------|------|----------------------|
| t _{d(on)} t _r t _{d(off)} t _f | Turn-on Time Rise Time Turn-off Delay Time Fall Time | V _{DD} = 30 V I _D = 10 A R _{GS} = 4.7 Ω V _{GS} = 10 V | | 20 45 48 10 | | ns ns ns ns |

ELECTRICAL CHARACTERISTICS (continued)

SOURCE DRAIN DIODE

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------------|----------------------------------------------------------|-----------------------------------------------------------------------------------------------|-------------|-------------|-------------|-------------|
| I _{SD} I _{SDM} | Source-drain Current Source-drain Current (pulsed) | | | | 23 92 | A A |
| V _{SD} (*) | Forward On Voltage | I _{SD} = 46 A V _{GS} = 0 | | | 1.9 | V |
| t _{rr} Q _{rr} | Reverse Recovery Time Reverse Recovery Charge | I _{SD} = 23 A di/dt = 100 A/μs V _{DD} = 30 V T _j = 150 °C | | 50 0.17 | | ns μC |

(*) Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

BUZ10

Fig. 1: Unclamped Inductive Load Test Circuit

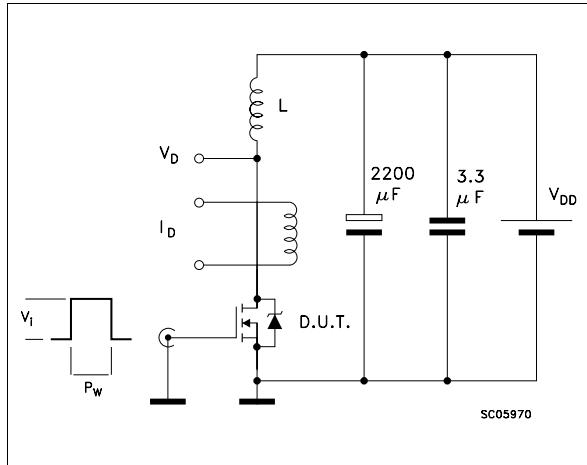


Fig. 2: Unclamped Inductive Waveform

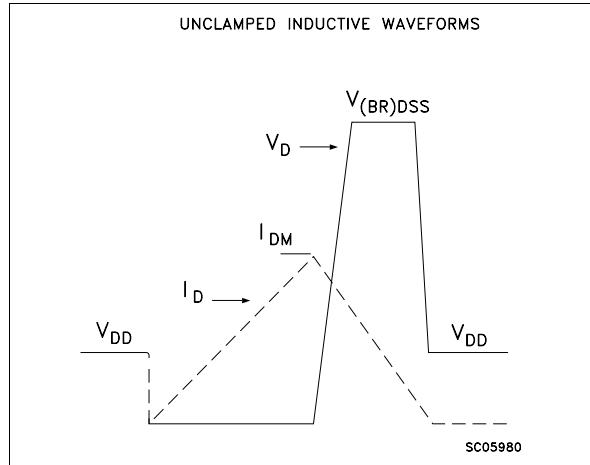


Fig. 3: Switching Times Test Circuits For Resistive Load

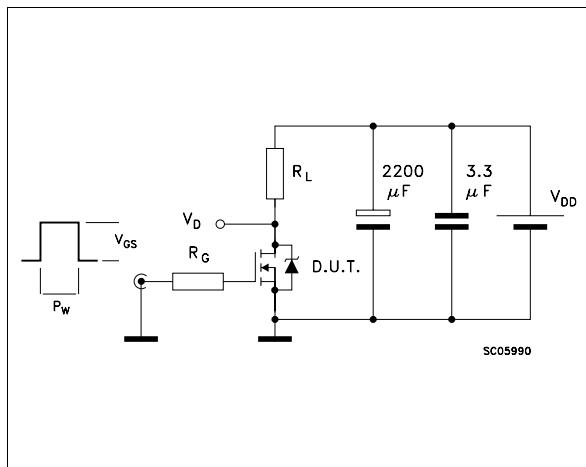


Fig. 4: Gate Charge test Circuit

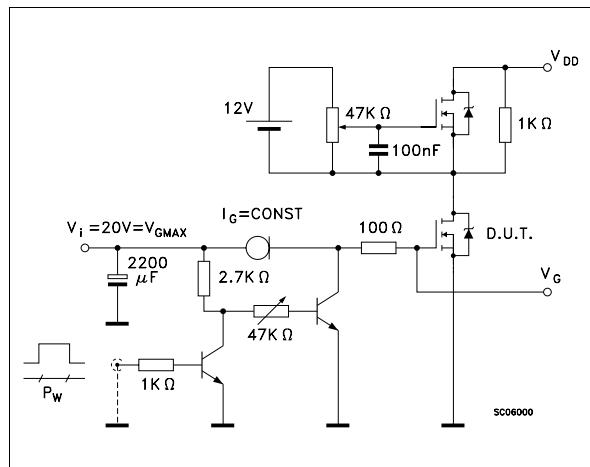
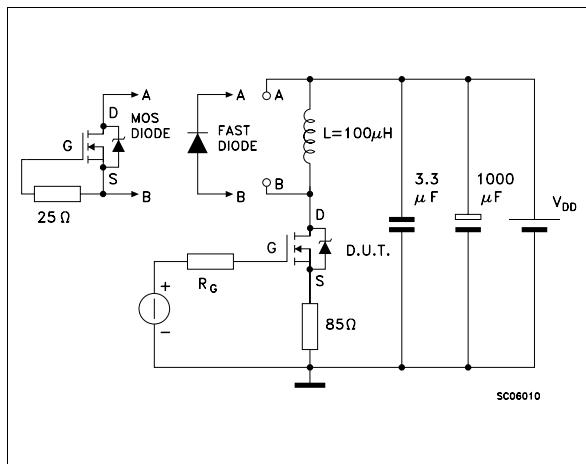
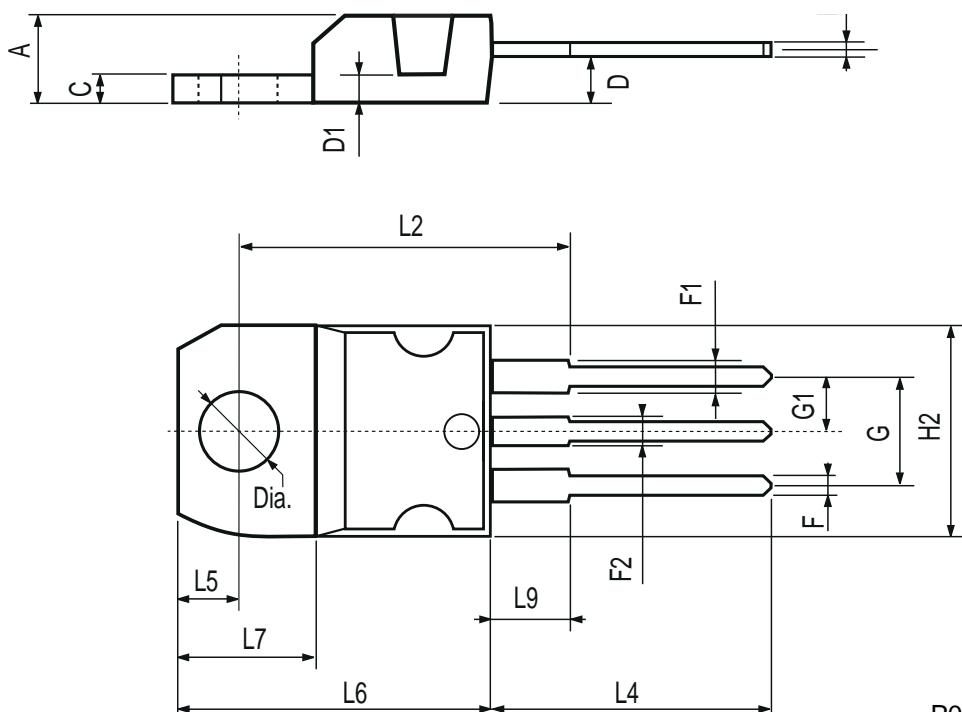


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times



TO-220 MECHANICAL DATA

| DIM. | mm | | | inch | | |
|------|-------|------|-------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A | 4.40 | | 4.60 | 0.173 | | 0.181 |
| C | 1.23 | | 1.32 | 0.048 | | 0.051 |
| D | 2.40 | | 2.72 | 0.094 | | 0.107 |
| D1 | | 1.27 | | | 0.050 | |
| E | 0.49 | | 0.70 | 0.019 | | 0.027 |
| F | 0.61 | | 0.88 | 0.024 | | 0.034 |
| F1 | 1.14 | | 1.70 | 0.044 | | 0.067 |
| F2 | 1.14 | | 1.70 | 0.044 | | 0.067 |
| G | 4.95 | | 5.15 | 0.194 | | 0.203 |
| G1 | 2.4 | | 2.7 | 0.094 | | 0.106 |
| H2 | 10.0 | | 10.40 | 0.393 | | 0.409 |
| L2 | | 16.4 | | | 0.645 | |
| L4 | 13.0 | | 14.0 | 0.511 | | 0.551 |
| L5 | 2.65 | | 2.95 | 0.104 | | 0.116 |
| L6 | 15.25 | | 15.75 | 0.600 | | 0.620 |
| L7 | 6.2 | | 6.6 | 0.244 | | 0.260 |
| L9 | 3.5 | | 3.93 | 0.137 | | 0.154 |
| DIA. | 3.75 | | 3.85 | 0.147 | | 0.151 |



P011C

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